


<b>Search Notes</b>  	<b>Application/Control No.</b>  09708129	<b>Applicant(s)/Patent Under Reexamination</b>  SPIEGEL, DAVID N.
	<b>Examiner</b>  Rutten, J. Derek	<b>Art Unit</b>  2197

SEARCHED			
Class	Subclass	Date	Examiner
717	170	4/22/2012	/jdr/

SEARCH NOTES		
Search Notes	Date	Examiner
Tuan Dam, AU 2192 and Wei Zhen, AU 2191 (consulted re. Appeal Brief)	4/22/2012	/jdr/
Updated search	4/22/2012	/jdr/
717/169,170,175; 707/705 - text search only - see search history printout	4/23/2012	/jdr/
EAST - see search history printout	4/23/2012	/jdr/
STIC NPL Multi-Search - see search history printout	4/23/2012	/jdr/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	717/169,170,175; 707/705 - text search only - see interference search history printout	4/23/2012	/jdr/
	EAST - see interference search history printout	4/23/2012	/jdr/

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